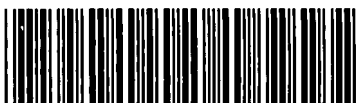


Search Notes

Application/Control No.

10/653,670

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

REID, LAURA

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	33 37 93.01 93.07 106.01 221.01	6/28/2005	QN
379	221.02	6/28/2005	QN
379	221.03	6/28/2005	QN
379	221.14	6/28/2005	QN
379	207.14	6/28/2005	QN
379	211.01	6/28/2005	QN
379	211.02	6/28/2005	QN
379	212.01	6/28/2005	QN
370	351 352 353 354 355 356	6/28/2005	QN
above	updated	1/19/06	QN
above	updated	7/9/06	QN
above	updated	12/15/06	QN
above	updated	7/2/07	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched: east	6/28/2005	QN
Inventor searched through PALM database	6/28/05	QN